


<b>Search Notes</b>  	<b>Application/Control No.</b>  10027163	<b>Applicant(s)/Patent Under Reexamination</b>  COUTS ET AL.
	<b>Examiner</b>  DJENANE M BAYARD	<b>Art Unit</b>  2444

SEARCHED			
Class	Subclass	Date	Examiner
709	201, 206, 207	9/30/09	db

SEARCH NOTES		
Search Notes	Date	Examiner
east	9/30/09	db
Double patenting Search	9/30/09	db
Consulted with P.E.	9/30/09	db

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
709	201, 206, 207	9/30/09	db

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